

STD7N60M2, STP7N60M2, STU7N60M2

N-channel 600 V, 0.86 Ω typ., 5 A MDmesh II Plus™ low Q_g Power MOSFET in DPAK, TO-220 and IPAK packages

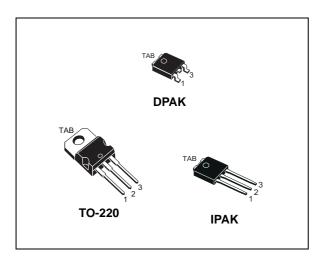
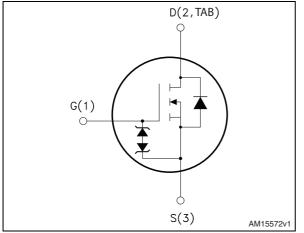


Figure 1. Internal schematic diagram



Features

Order codes	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STD7N60M2			
STP7N60M2	650 V	0.95 Ω	5 A
STU7N60M2			

Datasheet - production data

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

These devices are N-channel Power MOSFETs developed using a new generation of MDmeshTM technology: MDmesh II PlusTM low Q_g. These revolutionary Power MOSFETs associate a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. They are therefore suitable for the most demanding high efficiency converters.

Table	1.	Device	summary
Table		DCVICC	Summary

Order codes	Marking	Package	Packaging
STD7N60M2		DPAK	Tape and reel
STP7N60M2	7N60M2	TO-220	Tube
STU7N60M2		IPAK	Tube

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This is information on a product in full production.

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
Ι _D	Drain current (continuous) at T _C = 25 °C	5	А
Ι _D	Drain current (continuous) at T _C = 100 °C	3.5	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	20	А
P _{TOT}	Total dissipation at $T_{C} = 25 \text{ °C}$	60	W
dv/dt (1)	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽²⁾	MOSFET dv/dt ruggedness	50	V/115
T _{stg}	Storage temperature - 55 to 150		°C
Тj	Max. operating junction temperature	- 35 10 150	

Table 2. Absolute maximum ratings

1. I_{SD} \leq 5 A, di/dt \leq 400 A/µs; V_{DS peak} < V_{(BR)DSS}, V_{DD}=400 V

2. $V_{DS} \leq 480 \text{ V}$

Table 3. Thermal data

Symbol	Parameter		Value		
Symbol			TO-220	IPAK	Unit
R _{thj-case}	Thermal resistance junction-case max	2.08	2.08		°C/W
R _{thj-pcb}	Thermal resistance junction-pcb max ⁽¹⁾	50			°C/W
R _{thj-amb}	Thermal resistance junction-ambient max		62.5	100	°C/W

1. When mounted on 1 inch² FR-4, 2 Oz copper board

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	1.5	А
E _{AS}	Single pulse avalanche energy (starting $T_j=25$ °C, $I_D=I_{AR}$; $V_{DD}=50$)	99	mJ



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
	Zero gate voltage	V _{DS} = 600 V			1	μΑ
I _{DSS} drain current (drain current ($V_{GS} = 0$)	V _{DS} = 600 V, T _C =125 °C			100	μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 2.5 A		0.86	0.95	Ω

Table 5. On /off states

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	271	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	15.7	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	0.68	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	75.5	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	7.2	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 5 A,	-	8.8	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	1.8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 17)	-	4.3	-	nC

1. $C_{oss \ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 2.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 16</i> and <i>21</i>)	-	7.6	-	ns
t _r	Rise time		-	7.2	-	ns
t _{d(off)}	Turn-off delay time		-	19.3	-	ns
t _f	Fall time		-	15.9	-	ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)		-		5 20	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 5 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time		-	275		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 5 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 18</i>)	-	1.55		nC
I _{RRM}	Reverse recovery current		-	11		А
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/μs	-	376		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C	-	2.1		nC
I _{RRM}	Reverse recovery current	(see Figure 18)	-	11		А

Table 8. Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration = $300 \ \mu$ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for DPAK and

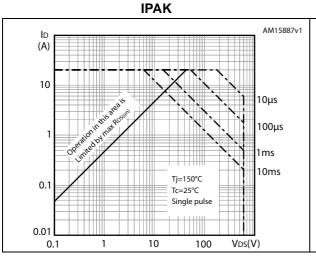


Figure 4. Safe operating area for TO-220

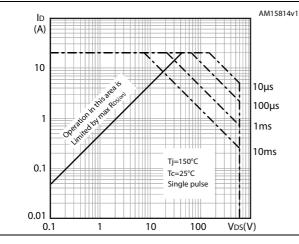


Figure 6. Output characteristics

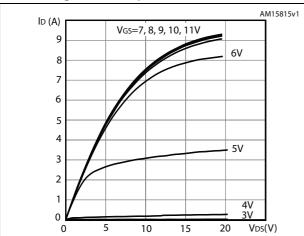
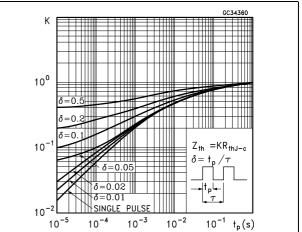


Figure 3. Thermal impedance for DPAK and IPAK





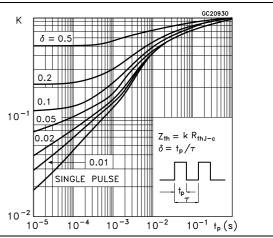


Figure 7. Transfer characteristics

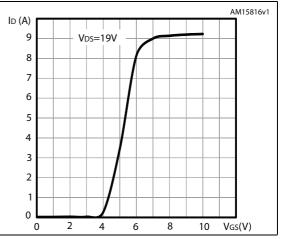
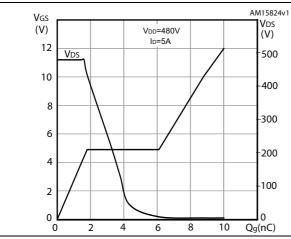




Figure 8. Gate charge vs gate-source voltage





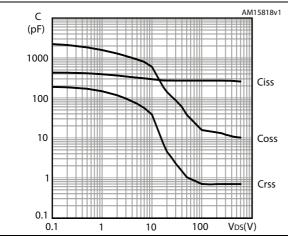
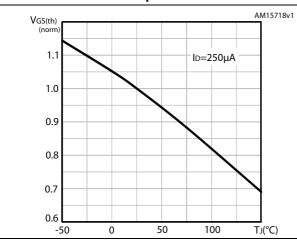


Figure 12. Normalized gate threshold voltage vs. temperature



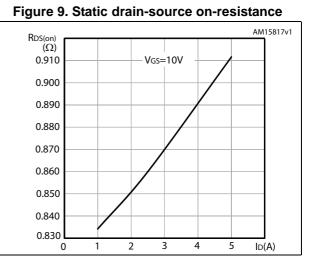


Figure 11. Output capacitance stored energy

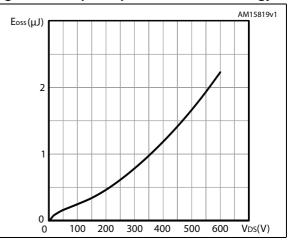


Figure 13. Normalized on-resistance vs. temperature

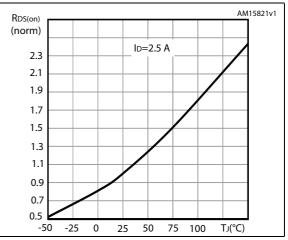
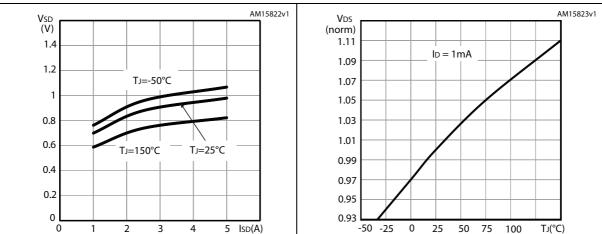




Figure 15. Normalized V_{DS} vs. temperature

Figure 14. Drain-source diode forward characteristics





3 Test circuits

Figure 16. Switching times test circuit for resistive load

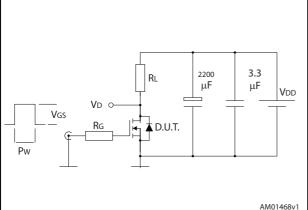


Figure 18. Test circuit for inductive load switching and diode recovery times

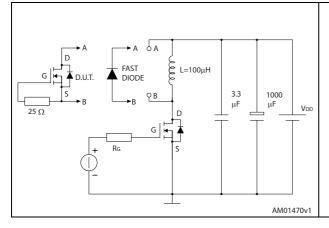


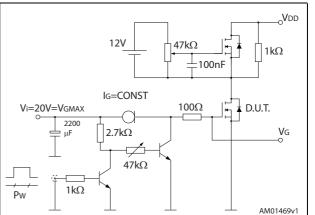
Figure 20. Unclamped inductive waveform

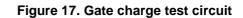
VD

ldм

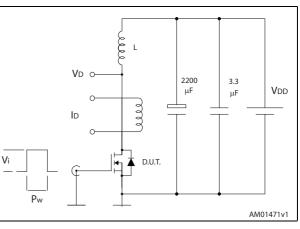
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V(BR)DSS









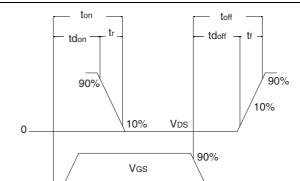


Figure 21. Switching time waveform



Vdd

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Vdd

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4 Package mechanical data

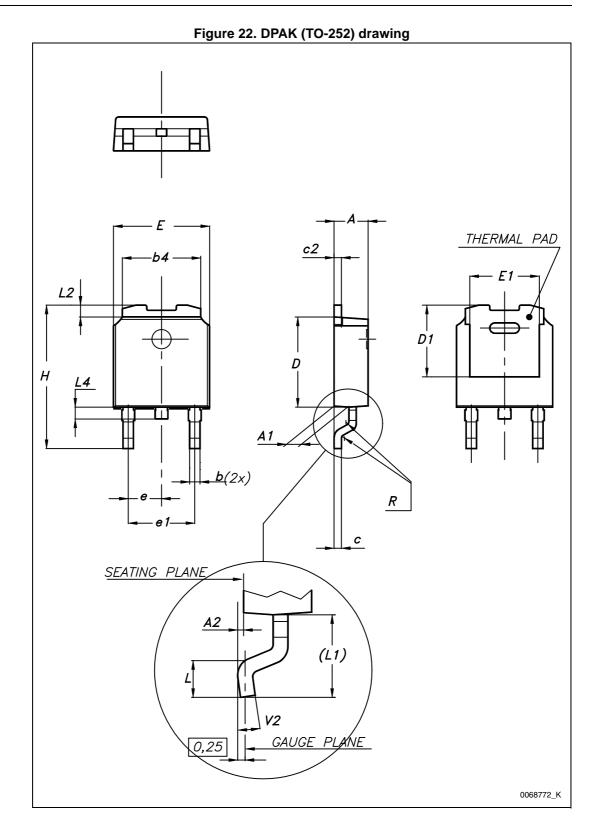
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Dim. —	mm			
	Min.	Тур.	Max.	
А	2.20		2.40	
A1	0.90		1.10	
A2	0.03		0.23	
b	0.64		0.90	
b4	5.20		5.40	
с	0.45		0.60	
c2	0.48		0.60	
D	6.00		6.20	
D1		5.10		
E	6.40		6.60	
E1		4.70		
е		2.28		
e1	4.40		4.60	
Н	9.35		10.10	
L	1.00		1.50	
(L1)		2.80		
L2		0.80		
L4	0.60		1.00	
R		0.20		
V2	0°		8°	

Table 9. DPAK (TO-252) mechanical data







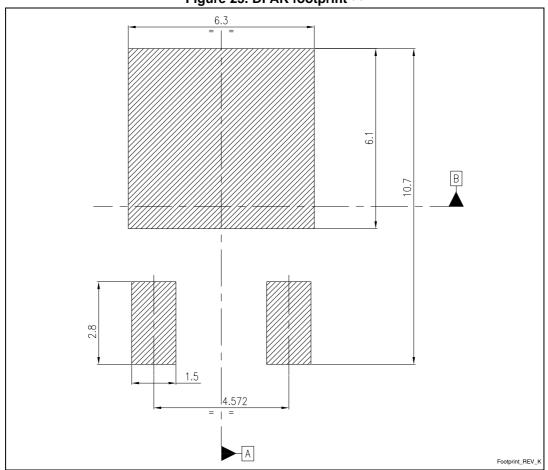


Figure 23. DPAK footprint ^(a)

a. All dimensions are in millimeters



	mm			
Dim. —	Min.	Тур.	Max.	
A	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
Øр	3.75		3.85	
Q	2.65		2.95	

Table 10. TO-220 type A mechanical data





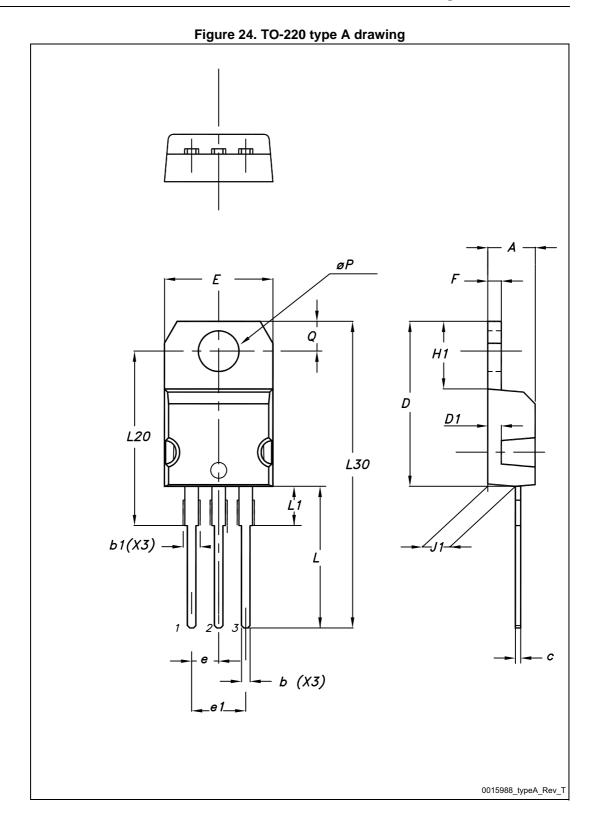




Table 11. IPAK (10-251) mechanical data				
DIM	mm.			
Dim	min.	typ.	max.	
А	2.20		2.40	
A1	0.90		1.10	
b	0.64		0.90	
b2			0.95	
b4	5.20		5.40	
B5		0.30		
С	0.45		0.60	
c2	0.48		0.60	
D	6.00		6.20	
E	6.40		6.60	
е		2.28		
e1	4.40		4.60	
Н		16.10		
L	9.00		9.40	
L1	0.80		1.20	
L2		0.80	1.00	
V1		10°		





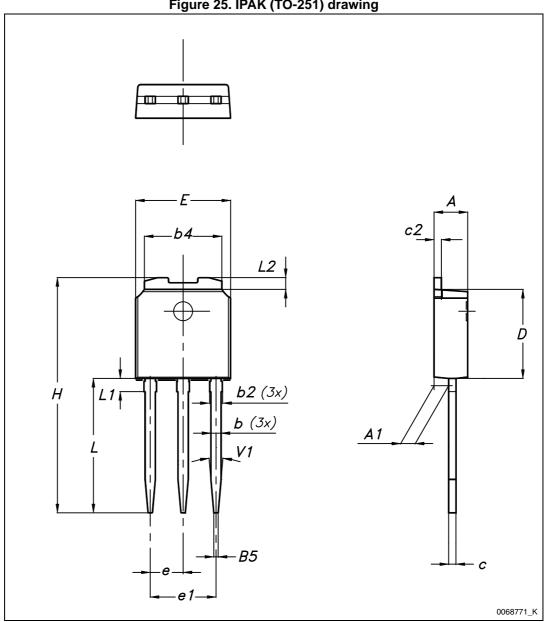


Figure 25. IPAK (TO-251) drawing



5 Packaging mechanical data

Таре				Reel		
Dim. –	mm		Dim	mm		
	Min.	Max.	— Dim.	Min.	Max.	
A0	6.8	7	А		330	
B0	10.4	10.6	В	1.5		
B1		12.1	С	12.8	13.2	
D	1.5	1.6	D	20.2		
D1	1.5		G	16.4	18.4	
Е	1.65	1.85	N	50		
F	7.4	7.6	Т		22.4	
K0	2.55	2.75				
P0	3.9	4.1		Base qty.	2500	
P1	7.9	8.1		Bulk qty.	2500	
P2	1.9	2.1				
R	40					
Т	0.25	0.35				
W	15.7	16.3				

Table 12. DPAK (TO-252) tape and reel mechanical data



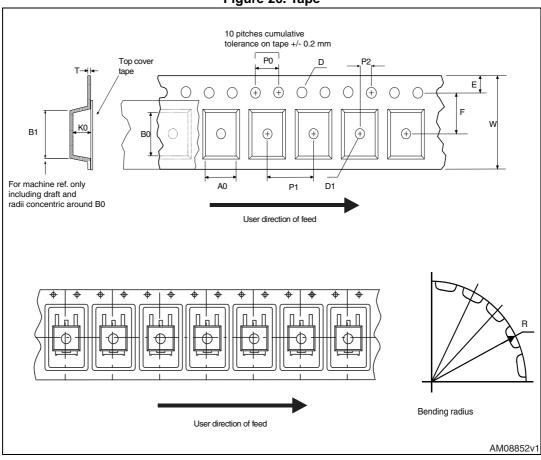
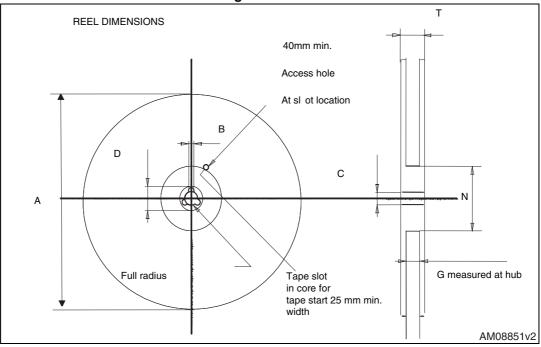


Figure 26. Tape

Figure 27. Reel





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6 Revision history

Table 13. Document revision history

Date	Revision	Changes
06-Jun-2013	1	First release.



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